N-Channel Enhancement Mode Power MOSFET

Description

The HM4260 uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. It can be used in a wide variety of applications.

General Features

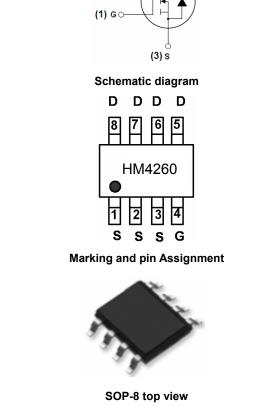
- $V_{DS} = 60V, I_D = 19A$ $R_{DS(ON)} < 11.5m\Omega @ V_{GS} = 10V$ (Typ:9.1m Ω)
- High density cell design for ultra low Rdson
- Fully characterized avalanche voltage and current
- Good stability and uniformity with high E_{AS}
- Excellent package for good heat dissipation
- Special process technology for high ESD capability

Application

- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible Power Supply

100% UIS TESTED!

100% ΔVds TESTED!



(2) D

Package Marking and Ordering Information

			0			
	Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
	HM4260	HM4260	SOP-8	-	-	-

Absolute Maximum Ratings (Tc=25°C unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	VDS	60	V
Gate-Source Voltage	Vgs	±20	V
Drain Current-Continuous	Ι _D	19	А
Drain Current-Continuous(T _C =100℃)	I _D (100℃)	13.5	А
Pulsed Drain Current	I _{DM}	75	A
Maximum Power Dissipation	PD	3	W
Derating factor		0.73	W/℃
Single pulse avalanche energy (Note 5)	E _{AS}	450	mJ
Operating Junction and Storage Temperature Range	T _J ,T _{STG}	-55 To 175	°C

Thermal Characteristic

Thermal Resistance, Junction-to-Case ^(Note 2)	R _{θJC}	1.36	°C /W	
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Electrical Characteristics (T_c=25°C unless otherwise noted)

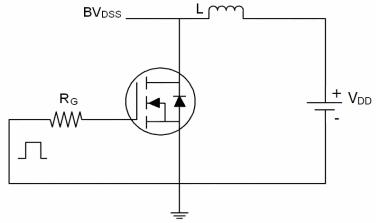
Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics	·	·	•			
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250µA	60	68	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =60V,V _{GS} =0V	-	-	1	μA
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±20V,V _{DS} =0V	-	-	±100	nA
On Characteristics (Note 3)	·	·	•			
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} ,I _D =250µA	2	3	4	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =15A	-	9.1	11.5	mΩ
Forward Transconductance	g fs	V _{DS} =25V,I _D =15A	20	-	-	S
Dynamic Characteristics (Note4)		·				
Input Capacitance	C _{lss}		-	2350	-	PF
Output Capacitance	C _{oss}	V _{DS} =25V,V _{GS} =0V, F=1.0MHz	-	237	-	PF
Reverse Transfer Capacitance	C _{rss}		-	205	-	PF
Switching Characteristics (Note 4)	·	·	•			
Turn-on Delay Time	t _{d(on)}		-	16	-	nS
Turn-on Rise Time	tr	V_{DD} =30V,I _D =2A,R _L =15 Ω	-	10	-	nS
Turn-Off Delay Time	t _{d(off)}	V _{GS} =10V,R _G =2.5Ω	-	45	-	nS
Turn-Off Fall Time	t _f		-	12	-	nS
Total Gate Charge	Qg)/ _20)// _454	-	50	-	nC
Gate-Source Charge	Q _{gs}	V _{DS} =30V,I _D =15A, V _{GS} =10V	-	12	-	nC
Gate-Drain Charge	Q _{gd}	V _{GS} -10V	-	16	-	nC
Drain-Source Diode Characteristics		·				
Diode Forward Voltage (Note 3)	V _{SD}	V _{GS} =0V,I _S =15A	-	-	1.2	V
Diode Forward Current (Note 2)	I _S		-	-	19	Α
Reverse Recovery Time	t _{rr}	TJ = 25°C, IF =19A	-	28		nS
Reverse Recovery Charge	Qrr	di/dt = 100A/µs(Note3)	-	49		nC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD				y LS+LD)

Notes:

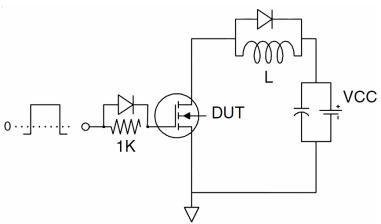
- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- **2.** Surface Mounted on FR4 Board, $t \le 10$ sec.
- **3.** Pulse Test: Pulse Width \leq 300µs, Duty Cycle \leq 2%.
- 4. Guaranteed by design, not subject to production
- 5. E_{AS} condition : Tj=25°C, V_{DD}=30V, V_G=10V, L=0.5mH, Rg=25\Omega

Test Circuit

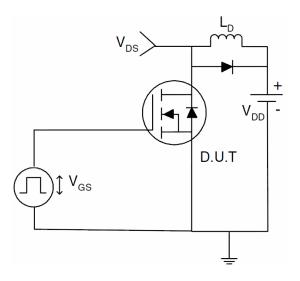
1) E_{AS} test Circuit

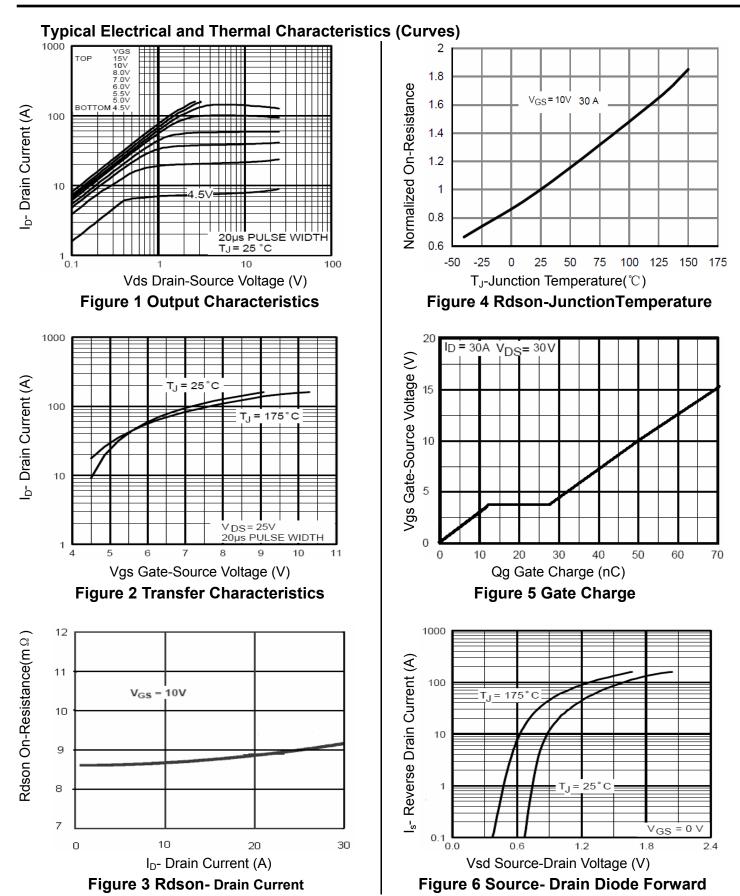


2) Gate charge test Circuit



3) Switch Time Test Circuit

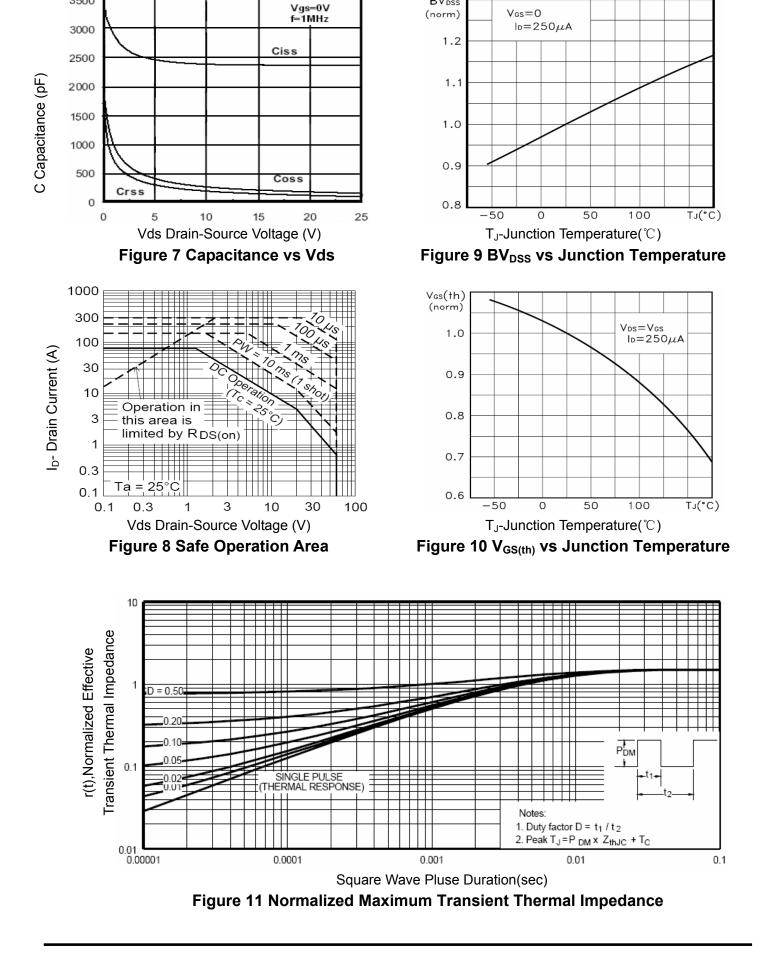






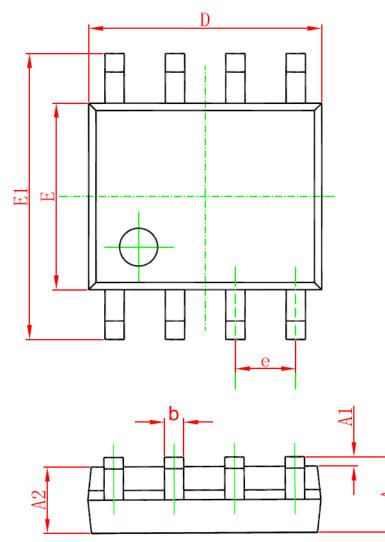
3500

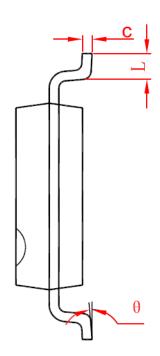
HM4260



BVDSS

SOP-8 PACKAGE IN FORMATION





Sumb a l	Dimensions Ir	n Millimeters	Dimensions In Inches		
Symbol	Min	Max	Min	Max	
А	1. 350	1. 750	0.053	0. 069	
A1	0. 100	0. 250	0.004	0. 010	
A2	1.350	1.550	0.053	0. 061	
b	0. 330	0. 510	0.013	0. 020	
с	0. 170	0. 250	0.006	0. 010	
D	4. 700	5. 100	0. 185	0. 200	
E	3.800	4.000	0. 150	0. 157	
E1	5. 800	6. 200	0. 228	0. 244	
е	1. 270 (BSC)		0. 050 (BSC)		
L	0. 400	1. 270	0.016	0. 050	
θ	0°	8°	0°	8°	

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